Search Notes



Application/Control No.

10009579

DE LEIJ ET AL.

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

Qian Ph.D., Celine X

1636

SEARCHED

		·	
Class	Subclass	Date	Examiner

QE		CH	NO	LEG
3E	MП	СП	IVU I	IES

Search Notes	Date	Examiner
Search updated.	9/15/06	CQ
Search updated	5/24/2007	CQ
Search updated	10/23/2007	CQ

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
			1